Search Notes

Ī	Application/Control No.	Applicant(s)/Patent under Reexamination	
Į	09/938,611	FUNAYAMA ET AL.	
ſ	Examiner	Art Unit	
	Tianjie Chen	2627	

	SEARCHED				
Class	Subclass	Date	Examiner		
360	318.1	6/20/2006	· TJ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
360	318.1	6/20/2006	TJ		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Report	6/20/2006	TJ